Search Notes	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/609,377	KANE ET AL.
Examiner	Art Unit
CUONG H. NGUYEN	3661

	SEARCHED			
Class	Subclass	Date	Examiner	
701	19,70	6/20/2007	CHN	
73	146	6/20/2007	CHN	
702	85	6/20/2007	CHN	
324	166	6/20/2007	CHN	
104	96,118	1	1	
105	154-155	1		
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INTERFERENCE SEARCHED							
Class	Subclass Date Exam   19,70 6/23/2007 CH		Subclass	Date		Exan	niner
701			6/23/2007		-IN		
73	146	١			i		
702	85						
	25/02 2/00,02	,			/		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
WEST/DERWENT frwrd/bkwrd searches on allowable subject matter and closest references	6/22/2007	CHN
Inventors'names searches	6/22/2007	CHN
IEEE Xplore	6/22/2007	CHN
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